## CS 446/ECE 449: Machine Learning

Lecture 10: PAC Learning Theory (II)

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#### Recap: Bayes Error

#### Bayes error rate:

Bayes error: 
$$\varepsilon_{\mu}^* := \inf_{f: \mathcal{X} \to \mathcal{Y}} \varepsilon_{\mu}(f)$$

#### Binary classification:

Bayes error rate: 
$$\varepsilon_{\mu}^* = \mathbb{E} \min \left\{ \Pr(Y = 1 | X), \Pr(Y = 0 | X) \right\}$$

Bayes optimal classifier: 
$$f_{\text{Bayes}}(X) := \begin{cases} 1 & \text{if } \Pr(Y = 1 | X) \ge \frac{1}{2} \\ 0 & \text{otherwise} \end{cases}$$

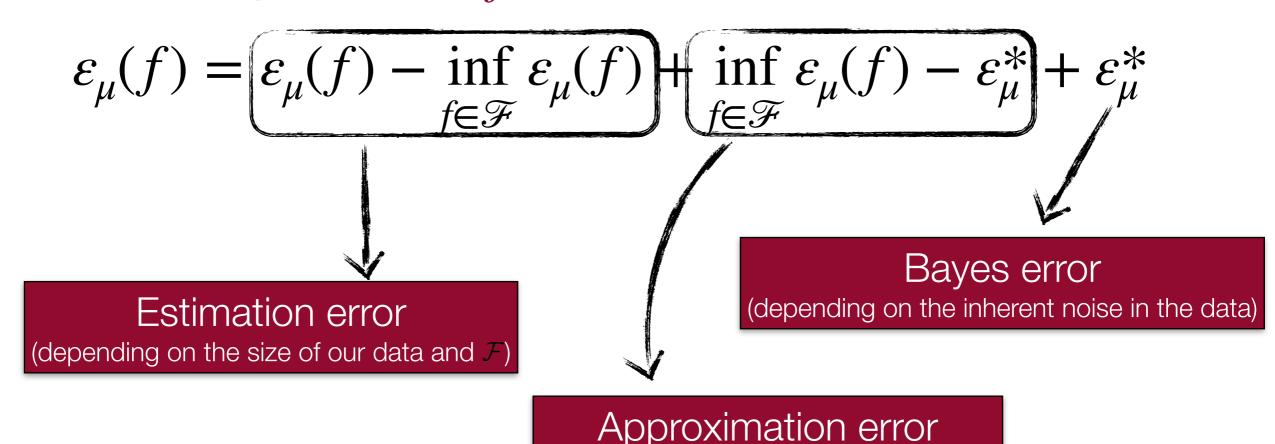
Regression with squared loss:

Bayes error rate:  $\varepsilon_{\mu}^* = \mathbb{E} \text{Var}[Y|X]$ 

Bayes optimal regressor:  $f_{\text{Bayes}}(X) = \mathbb{E}[Y|X]$ 

#### Recap: Error Decomposition

#### Error decomposition: $\forall f \in \mathcal{F}$ :



- (depending on the expressiveness of  $\mathcal{F}$ )
- Often the case, there is a trade-off between the estimation error and the approximation error
- If  $\mathscr{F}$  is more expressive, then the approximation error gets smaller but the estimation error gets larger
- If  $\mathcal{F}$  is more restricted, then the approximation error gets larger but the estimation error gets smaller (assume the size of training data is fixed)

#### Lecture Today

- Probably Approximately Correct (PAC) framework
- Generalization analysis
- Vapnik-Chervonenkis dimension (VC dim)

#### The learning process:

- We can choose a predictor f from some pre-defined class of functions  $\mathcal{F}$ , e.g., the class of linear predictors, decision trees, kernel machines, neural networks, etc.

We also have our training data  $\mathcal{D}:=\{(x^{(i)},y^{(i)})\}_{i=1}^n\sim \mu$  sampled independently and identically (iid) from the underlying distribution  $\mu$  over  $\mathcal{X}\times\mathcal{Y}$ 

We can then talk about two error measures (classification):

Training error: 
$$\hat{\varepsilon}_{\mathcal{D}}(f) := \frac{1}{n} \sum_{i=1}^{n} \mathbb{I}(f(x^{(i)}) \neq y^{(i)})$$

Test error: 
$$\varepsilon_{\mu}(f) := \mathbb{E}_{\mu} \left[ \mathbb{I}(f(X) \neq Y) \right] = \Pr_{\mu}(f(X) \neq Y)$$

We are interested in finding f that minimizes the test error but we can only observe the training error

For a given hypothesis class  $\mathcal{F}$ , can we relate the training and test errors?

Generalization error/gap: 
$$|\hat{\varepsilon}_{\mathcal{D}}(f) - \varepsilon_{\mu}(f)|$$

#### Note:

- The generalization error is a random variable due to the randomness in  $\mathscr{D} \sim \mu$
- For any fixed f, we would expect the generalization error to be small:

$$\mathbb{E}\left[\hat{\varepsilon}_{\mathcal{D}}(f)\right] = \mathbb{E}\left[\frac{1}{n}\sum_{i=1}^{n}\mathbb{I}(f(x^{(i)}) \neq y^{(i)})\right] = \frac{1}{n}\sum_{i=1}^{n}\mathbb{E}\left[\mathbb{I}(f(x^{(i)}) \neq y^{(i)})\right] = \varepsilon_{\mu}(f)$$

The argument above is in expectation, and it does not necessarily apply to our specific training data  $\mathcal{D}$ . How about we consider a high-probability guarantee instead?

#### Probably Approximately Correct (PAC, Valiant, CACM 1984)

- (Informal) A framework to quantify the meaning of learning a concept from samples
- With high probability (P), the learned predictor will have low generalization error (AC)
- No distributional assumption

A Theory of the Learnable

L. G. VALIANT

nerits similar attention. The problem is to discover neers similar accuming. The promein is to discover good models that are interesting to study for their own ake and that promise to be relevant both to explaining tuman experience and to building devices that can earn. The models should also shed light on the limits of what can be learned, just as computability does on

ong human skills some clearly appear to have

what algorithm we are really using. In these cases it would be specially significant if machines could be made to acquire them by learning.

This paper is concerned with procise computational models of the learning phenomenon. We shall restrict ourselves to skills that consist of recognizing whether concept (or predicate) is true or not for given data. We shall say that a concept Q has been learned if a program for recognizing it has been deduced (i.e., by som method other than the acquisition from the outside of the explicit more run.

the explicit program).

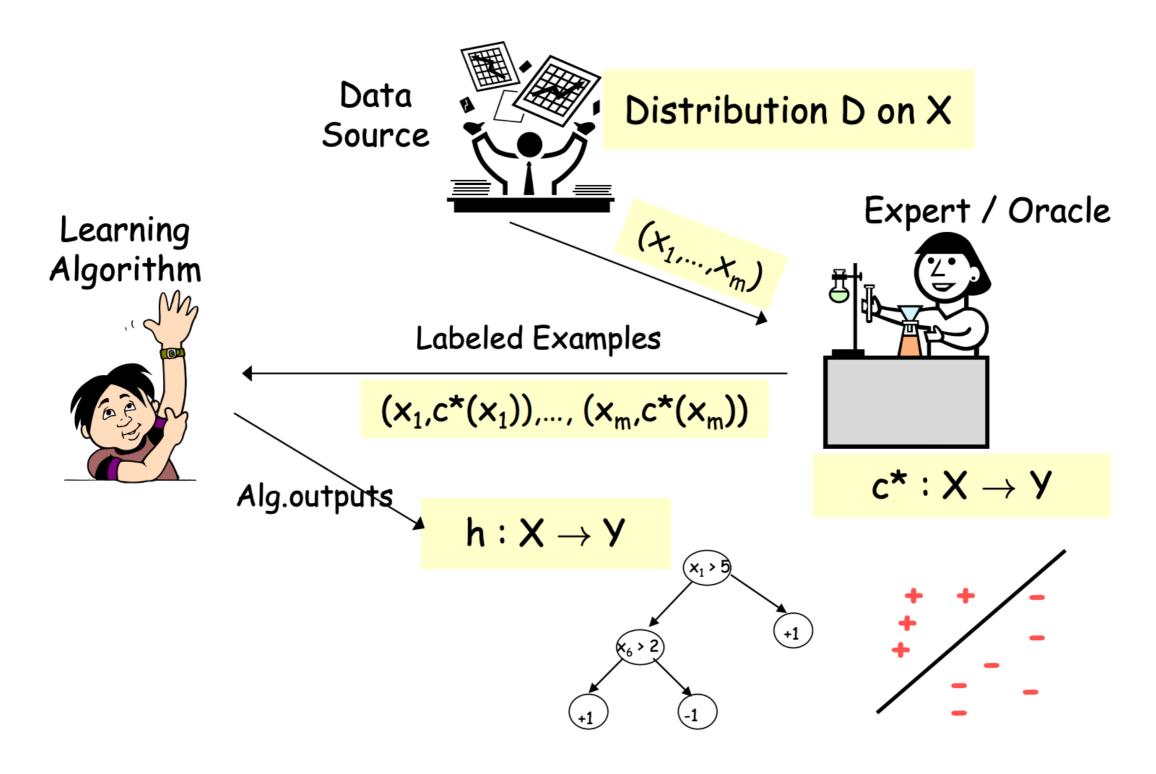
The main contribution of this paper is that it show that it is possible to design *learning machines* that have all three of the following properties:

- vial for general-purpose knowledge.
  The computational process by which the machines deduce the desired programs requires a feasible (i.e., polynomial) number of steps.

A learning machine consists of a learning protocol to



Probably Approximately Correct (PAC, Valiant, CACM 1984)



Probably Approximately Correct (PAC, Valiant, CACM 1984)

Definition (PAC-learnable): A concept class  $\mathscr{F}$  is said to be PAC-learnable if there exists an algorithm  $\mathscr{A}$  such that for any  $0<\varepsilon,\delta<1$ , for any distribution  $\mu$  over  $\mathscr{X}$  and for any target concept  $c\in\mathscr{F}$ , the following holds for any sample size  $n\geq \operatorname{poly}(1/\varepsilon,1/\delta,d)$ :

$$\Pr_{\mathcal{D}}(\varepsilon_{\mu}(f) \le \epsilon) \ge 1 - \delta$$

where f is the output of the algorithm  $\mathscr{A}$ .

- $\epsilon$  is called the accuracy parameter
- $\delta$  is called the confidence parameter

Probably Approximately Correct (PAC, Valiant, CACM 1984)

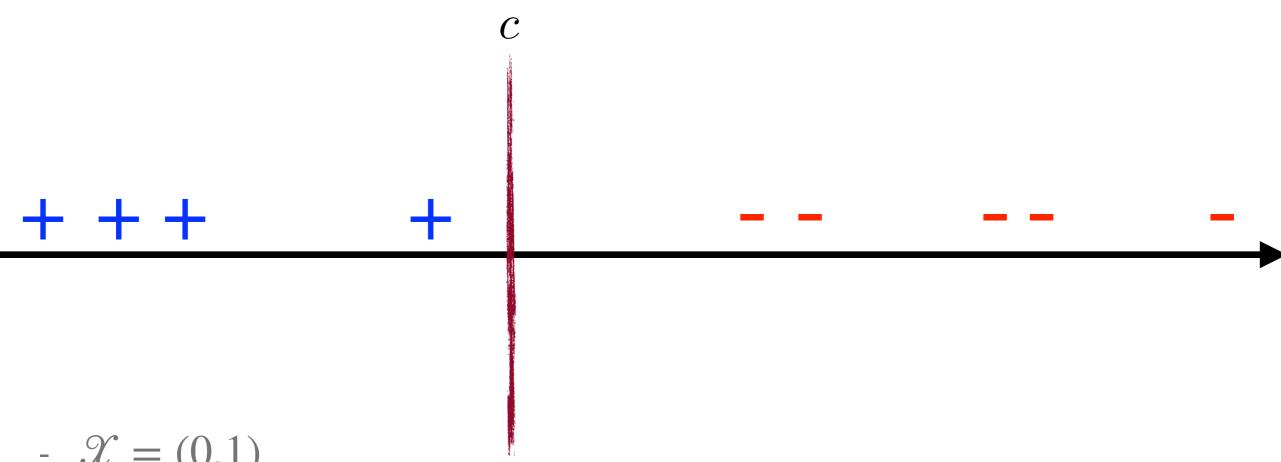
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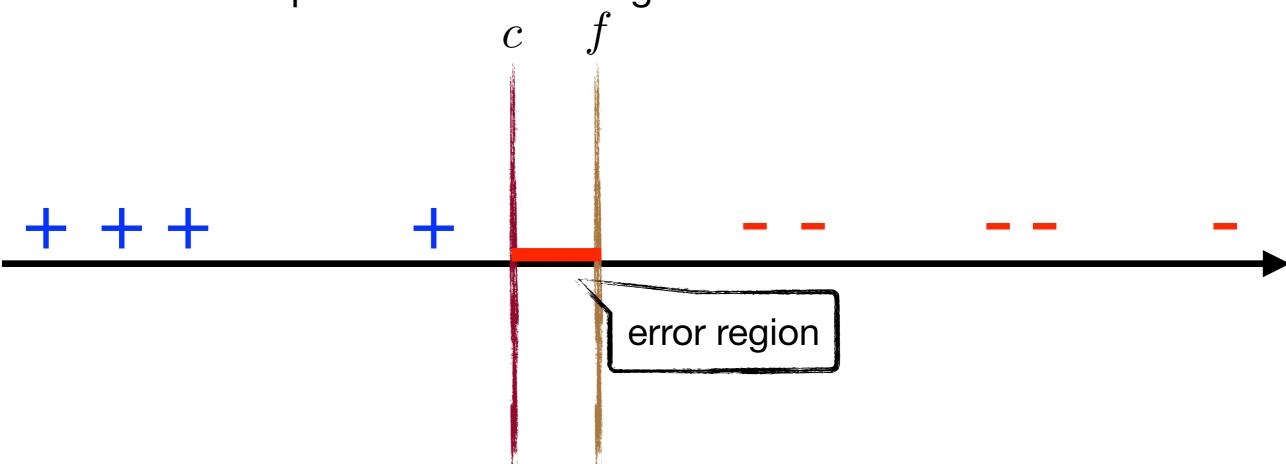
- This holds for arbitrary target concept
- No assumption on the distribution  $\mu$
- PAC-learnability does not mention about the time complexity of running
- The polynomial  $poly(1/\epsilon, 1/\delta, d)$  is called the sample complexity of  $\mathcal A$

A running example: learning with initial-segment



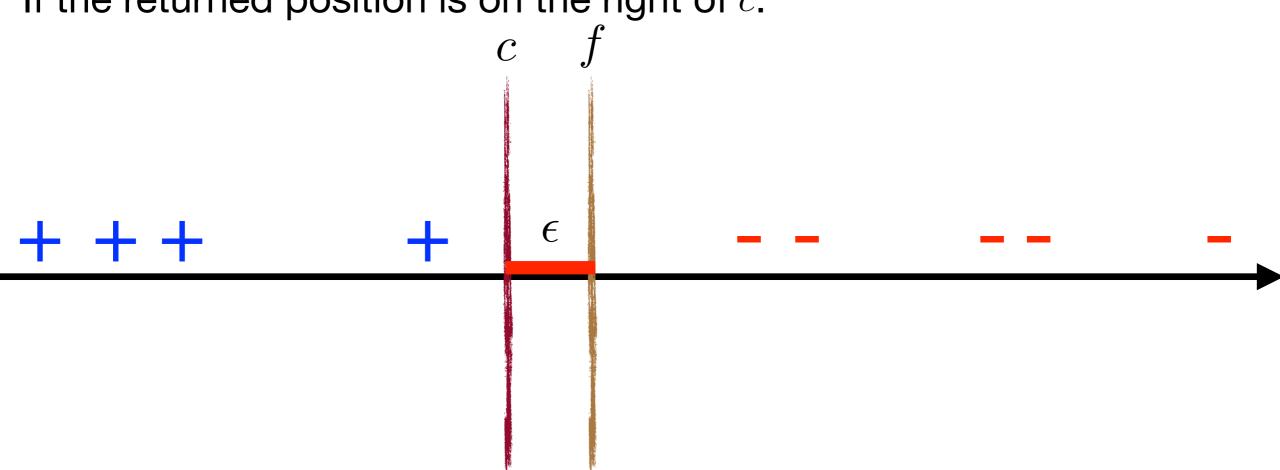
- $-\mathcal{X} = (0,1)$
- $\mathcal{F} = \{c_a \in 2^{(0,1)} \mid c_a(x) = 1 \iff x \le a\}$
- Let's consider a simple algorithm: return  $f = (\max x + \min x)/2$ *x*:*x*∈+  $x:x \in -$
- Assume the distribution over  ${\mathscr X}$  to be uniform

If the returned position is on the right of c:



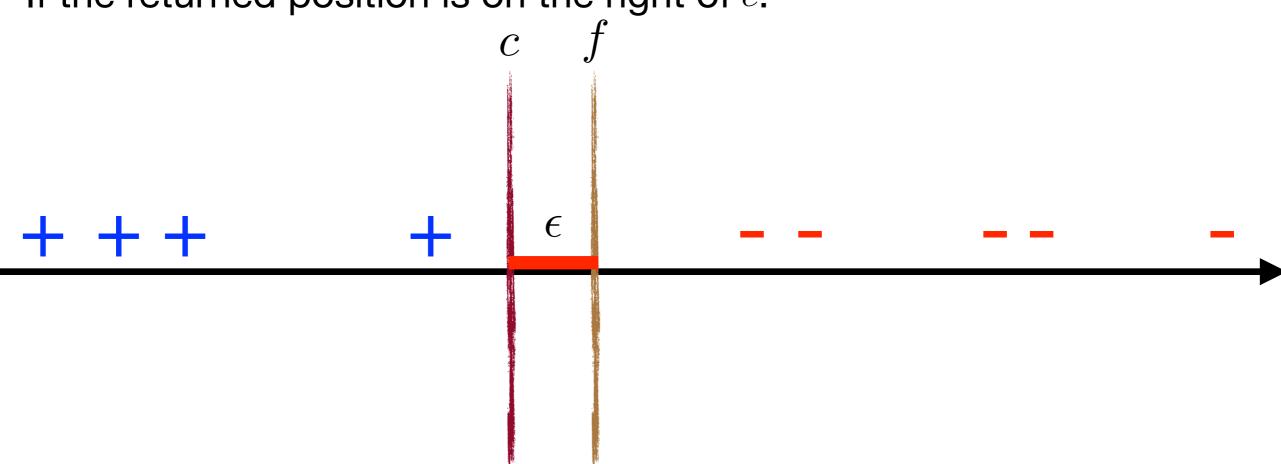
- Error only happens at the interval between c and f
- We want to upper bound the error probability:  $\Pr(\varepsilon_{\mu}(f) \ge \epsilon)$

If the returned position is on the right of c:



- Claim: there is no point in the training data from  $\mu$  that lies in this interval (?)

If the returned position is on the right of c:



$$\Pr(\varepsilon_{\mu}(f) \ge \epsilon | f \text{ on the right of } c)$$

 $\leq$  Pr(none of the training data lies in the interval)

$$\leq (1 - \epsilon)^n$$

$$\leq \exp(-n\epsilon)$$

iid assumption

$$\forall x, 1 - x \le \exp(-x)$$

Similarly, if the returned position is on the left of c:

$$\Pr(\varepsilon_{\mu}(f) \ge \epsilon | f \text{ on the left of } c) \le \exp(-n\epsilon)$$

Now, by a union bound  $(\Pr(A \cup B) \le \Pr(A) + \Pr(B))$ , and let L = f on the left of c and R = f on the right of c

$$\Pr(\varepsilon_{\mu}(f) \geq \epsilon) = \Pr(\varepsilon_{\mu}(f) \geq \epsilon \mid L) \Pr(L) + \Pr(\varepsilon_{\mu}(f) \geq \epsilon \mid R) \Pr(R)$$

$$\leq \Pr(\varepsilon_{\mu}(f) \geq \epsilon \mid L) + \Pr(\varepsilon_{\mu}(f) \geq \epsilon \mid R)$$

$$\leq 2 \exp(-n\epsilon)$$

$$\leq \delta$$

Solving for *n*, we get: it suffices if

$$n \ge \frac{1}{\epsilon} \log \frac{1}{\delta}$$

This shows that  $\mathcal{F}$  is PAC-learnable.

Could we generalize the previous results?

Realizable case with finite  $\mathcal{F}$ :  $|\mathcal{F}| < \infty, c \in \mathcal{F}$ 

Theorem: Let f be an empirical risk minimizer on a training data with

$$n \ge \frac{1}{\epsilon} \left( \log |\mathcal{F}| + \log \frac{1}{\delta} \right)$$

Then  $\Pr(\varepsilon_{\mu}(f) \leq \epsilon) \geq 1 - \delta$ . Equivalently, with probability at least

$$1 - \delta$$
:

$$\varepsilon_{\mu}(f) \le \frac{1}{n} \left( \log |\mathcal{F}| + \log \frac{1}{\delta} \right)$$

**Empirical Risk Minimization (ERM):** 

$$f_{\text{ERM}} = \mathcal{A}_{\text{ERM}}(\mathcal{D}) := \arg\min_{f \in \mathcal{F}} \frac{1}{n} \sum_{i=1}^{n} \mathbb{I}(f(x^{(i)}) \neq y^{(i)})$$

i.e., the ERM algorithm finds a predictor that minimizes the training loss

Realizable case with finite  $\mathcal{F}$ :  $|\mathcal{F}| < \infty, c \in \mathcal{F}$ 

Theorem: Let f be an empirical risk minimizer on a training data with

*n* examples where 
$$n \ge \frac{1}{\epsilon} \left( \log |\mathcal{F}| + \log \frac{1}{\delta} \right)$$

Then  $\Pr(\varepsilon_{\mu}(f) \leq \epsilon) \geq 1 - \delta$ . Equivalently, with probability at least

$$1 - \delta:$$

$$\varepsilon_{\mu}(f) \le \frac{1}{n} \left( \log |\mathcal{F}| + \log \frac{1}{\delta} \right)$$

- Fact: since we are using ERM under realizable case, the training error of the ERM solution will be 0
- Let's fix a classifier f and consider its true error. Instead, let  $f_{\rm ERM}$  be the solution returned by the ERM algorithm

By definition of conditional probability:

$$\Pr\left(\widehat{\varepsilon}_{\mathcal{D}}(f) = 0 \land \varepsilon_{\mu}(f) > \epsilon\right) \leq \Pr\left(\widehat{\varepsilon}_{\mathcal{D}}(f) = 0 \mid \varepsilon_{\mu}(f) > \epsilon\right)$$

But,

$$\Pr\left(\widehat{\varepsilon}_{\mathcal{D}}(f) = 0 \mid \varepsilon_{\mu}(f) > \epsilon\right) \leq (1 - \epsilon)^{n}$$

Hence, by union bound,

$$\Pr\Big(\exists f \in \mathcal{F} : \widehat{\varepsilon}_{\mathcal{D}}(f) = 0 \land \varepsilon_{\mu}(f) > \varepsilon\Big) \leq |\mathcal{F}| \cdot (1 - \varepsilon)^n \leq \delta$$

On the other hand, we have

$$\Pr(\varepsilon_{\mu}(f_{\text{ERM}}) > \epsilon) = \Pr(\widehat{\varepsilon}_{\mathcal{D}}(f_{\text{ERM}}) = 0 \land \varepsilon_{\mu}(f_{\text{ERM}}) > \epsilon)$$

$$\leq \Pr\left(\exists f \in \mathcal{F} : \widehat{\varepsilon}_{\mathcal{D}}(f) = 0 \land \varepsilon_{\mu}(f) > \epsilon\right)$$

$$\leq |\mathcal{F}| (1 - \epsilon)^{n} \leq |\mathcal{F}| \exp(-n\epsilon) \leq \delta$$

Solving for n, we get

$$n \ge \frac{1}{\epsilon} \left( \log |\mathcal{F}| + \log \frac{1}{\delta} \right)$$

### Probably Approximately Correct (Agnostic)

So far we mainly talk about realizable case with finite hypothesis class. Probably Approximately Correct (agnostic case)

Definition (PAC-learnable): A hypothesis space  $\mathscr{H}$  is said to be agnostic PAC-learnable if there exists an algorithm  $\mathscr{A}$  such that for any  $0<\varepsilon,\delta<1$ , for all distribution  $\mu$  over  $\mathscr{X}\times\mathscr{Y}$ , the following holds for any sample size  $n\geq \mathrm{poly}(1/\varepsilon,1/\delta,d)$ :

$$\Pr\left(\varepsilon_{\boldsymbol{\mu}}(f) \leq \min_{f' \in \mathcal{H}} \varepsilon_{\boldsymbol{\mu}}(f') + \epsilon\right) \geq 1 - \delta$$

where f is the output of the algorithm  $\mathscr{A}$ .

- $\epsilon$  is called the accuracy parameter
- $\delta$  is called the confidence parameter
- No assumption on  $\mu$  has been made
- Agnostic PAC-learnability does not mention about the time complexity of running
- The polynomial  $poly(1/\epsilon, 1/\delta, d)$  is called the sample complexity of  $\mathcal{A}$

### Concentration Inequality

Some useful inequalities regarding the concentration of RVs

Theorem (Hoeffding's inequality): Let  $Z_1, \ldots, Z_n$  be independent RVs where  $Z_i \in [a,b]$ . The for any  $\epsilon>0$ , the following inequality hold for the mean  $\bar{Z}_n=\frac{1}{n}\sum_{i=1}^n Z_i$ :

$$\Pr\left(\left|\bar{Z}_n - \mathbb{E}[\bar{Z}_n]\right| \ge \epsilon\right) \le 2\exp\left(-\frac{2n\epsilon^2}{(b-a)^2}\right)$$

Equivalent statement: with probability at least  $1 - \delta$ , we have:

$$\left|\bar{Z}_n - \mathbb{E}[\bar{Z}_n]\right| \le (b-a)\sqrt{\frac{\log(2/\delta)}{2n}}$$

If  $Z_1, ..., Z_n$  are iid, then  $\mathbb{E}[\bar{Z}_n] = \mathbb{E}[Z_i], \forall i \in [n]$  so we have

$$\left|\bar{Z}_n - \mathbb{E}[Z_1]\right| \le (b-a)\sqrt{\frac{\log(2/\delta)}{2n}}$$

### Concentration Inequality

Some useful inequalities regarding the concentration of RVs

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#### Example: Coin flipping

- Suppose we have a coin with head probability *p*
- We flipped the coin for 1000 times, with an average head frequency  $\hat{p}$
- How close will the frequency  $\hat{p}$  be to the true p?

For any fixed  $f \in \mathcal{F}$ , we can use the Hoeffding's inequality to get a generalization bound:

Let 
$$Z_i = \mathbb{I}(f(X^{(i)}) \neq Y^{(i)}) \in \{0,1\} \subseteq [0,1]$$
, then

Training error: 
$$\bar{Z}_n = \frac{1}{n} \sum_{i=1}^n Z_i = \frac{1}{n} \sum_{i=1}^n \mathbb{I}(f(X^{(i)}) \neq Y^{(i)}) = \hat{\varepsilon}_{\mathcal{D}}(f)$$

Test error: 
$$\mathbb{E}\left[\bar{Z}_n\right] = \mathbb{E}\left[Z_1\right] = \varepsilon_{\mu}(f)$$

By Hoeffding's inequality, with probability at least  $1 - \delta$ , we have

$$\varepsilon_{\mu}(f) \le \hat{\varepsilon}_{\mathcal{D}}(f) + \sqrt{\frac{\log(2/\delta)}{2n}}$$

Note: it is important to fix a predictor f in order for the analysis above to hold, i.e., f cannot be the output of an algorithm  $\mathscr A$  that depends on the data  $\mathscr D$ 

#### What if $f = \mathcal{A}(\mathcal{D})$ ?

Given  $\mathcal{D} = \{(x^{(i)}, y^{(i)})\}_{i=1}^n \sim \mu$  be a dataset of iid samples. Define our algorithm as follows:

$$f(x) := \begin{cases} y_i & \text{if } x = x_i \\ \text{"unknown"} & \text{otherwise} \end{cases}$$

Then 
$$\hat{\varepsilon}_{\mathcal{D}}(f) = 0$$
 and  $\varepsilon_{\mu}(f) = 1!$ 

#### Why?

- Hoeffding's inequality cannot be applied anymore, since f is the outcome of an algorithm  $\mathscr A$  that depends on the data  $\mathscr D$ . In other words, given f, the data  $Z_i$  are no longer independent

#### Fix?

- Use a disjoint validation set to empirically estimate the error
- Pay a model complexity penalty term: with probability at least  $1-\delta$ , for all  $f\in \mathcal{F}$  simultaneously, we have:

$$\varepsilon_{\mu}(f) \leq \hat{\varepsilon}_{\mathcal{D}}(f) + O\left(\sqrt{\frac{\text{complexity}(\mathcal{F}) + \log(1/\delta)}{n}}\right)$$

### Vapnik-Chervonenkis dimension (VC-dim)

#### VC dimension:

Let  $\mathscr{F}: \mathbb{R}^d \to \{0,1\}$  be a set of binary functions. Then the VC dimension of  $\mathscr{F}$ , denoted by  $VCdim(\mathscr{F})$  is the cardinality of the largest set of points in  $\mathbb{R}^d$  that can be shattered by  $\mathscr{F}$ .

#### Shattering:

Given a set  $\mathcal{D} \subseteq \mathbb{R}^d$  of size n, i.e.,  $|\mathcal{D}| = n$ , we say that  $\mathcal{D}$  can be shattered by  $\mathcal{F}$  iff

$$\forall S \subseteq \mathcal{D}, \exists f \in \mathcal{F} : \forall x \in S, f(x) = 1, \forall x \notin S, f(x) = 0$$

#### Note:

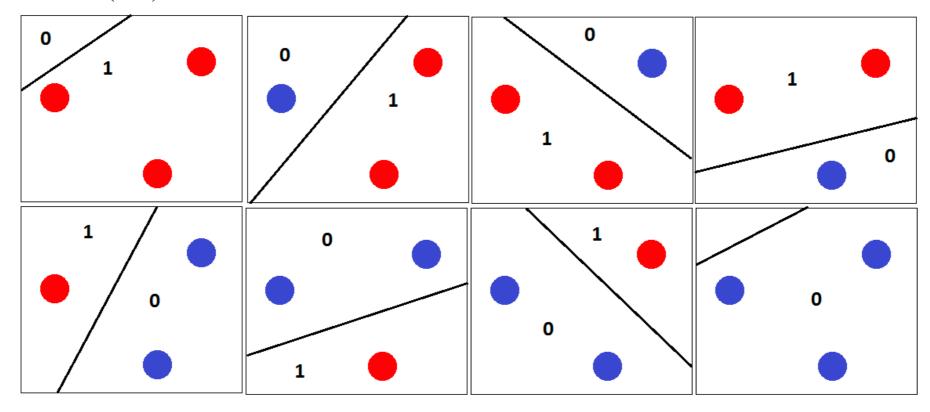
- By definition, in order to claim the VC-dim of a given hypothesis class  $\mathcal{F}$  to be n, we need to verify the following two conditions:
  - ★ VCdim( $\mathscr{F}$ )  $\geq n$ :  $\exists \mathscr{D} \subseteq \mathbb{R}^d : |\mathscr{D}| = n, \mathscr{F}$  shatters  $\mathscr{D}$
  - ★ VCdim( $\mathscr{F}$ )  $\leq n$ :  $\forall \mathscr{D} \subseteq \mathbb{R}^d$ :  $|\mathscr{D}| = n + 1, \mathscr{D}$  cannot be shattered by  $\mathscr{F}$

### Vapnik-Chervonenkis dimension (VC-dim)

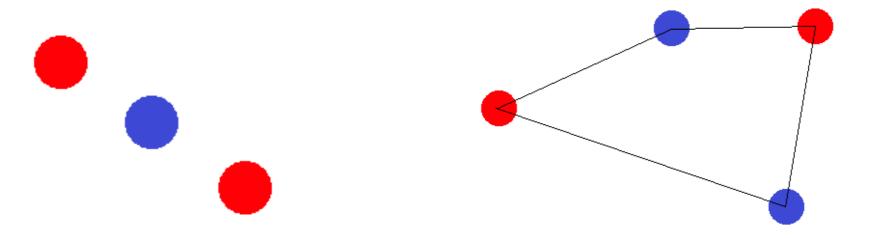
Example:  $d = 2, \mathcal{F} = \{\text{linear classifiers in } \mathbb{R}^2\}$ 

Claim:  $VCdim(\mathcal{F}) = 3$ 

Proof that  $VCdim(\mathcal{F}) \geq 3$ :



Proof that  $VCdim(\mathcal{F}) < 4$ : XOR



# With VC dim as the complexity measure, we have the following uniform generalization bound:

Given  $\mathscr{D} = \{(x^{(i)}, y^{(i)})\}_{i=1}^n \sim \mu$  be a dataset of iid samples. Let  $\mathscr{F}$  be a hypothesis class of finite VC-dim, i.e.,  $VCdim(\mathscr{F}) < \infty$ , then for  $0 < \delta < 1$ , with probability at least  $1 - \delta$ , for all  $f \in \mathscr{F}$ :

$$\varepsilon_{\mu}(f) \leq \hat{\varepsilon}_{\mathcal{D}}(f) + O\left(\sqrt{\frac{\text{VCdim}(\mathcal{F}) + \log(1/\delta)}{n}}\right)$$

#### Note:

- As long as  $VCdim(\mathcal{F}) < \infty$ , as  $n \to \infty$ , we know that the training error converges to the test error
- The bound above gives the generalization error, and we can use the generalization error bound to provide an upper bound on the estimation error, i.e.,  $\varepsilon_{\mu}(f) \inf_{f' \in \mathscr{F}} \varepsilon_{\mu}(f')$
- There are other forms of complexity measures to characterize the expressiveness/ richness/powerfulness of a given hypothesis class, but it is beyond the scope of this course
- The bound above could be loose, i.e., the generalization error could be larger than 1 for classification problems

#### **Next Time**

- Perceptron Algorithm
- Deep Learning